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|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/733,061 | | Applicant(s)/Patent Under Reexamination DESCHENES ET AL. | |
| | Examiner James R. Brittain | | Art Unit 3677 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------------|----------------|
| * | A | US-D273,177 | 03-1984 | Tcherneshoff, John K. | D8/382 |
| * | B | US-1,815,624 | 07-1931 | DEMPSTER KEILLOR JOSEPH | 24/102A |
| * | C | US-2,645,833 | 07-1953 | WISTEDT AXEL G | 24/711.1 |
| * | D | US-3,399,432 | 09-1968 | MERSER FRANCIS G | 24/114.7 |
| * | E | US-3,608,157 | 09-1971 | Molt | 24/102T |
| * | F | US-3,733,657 | 05-1973 | Lankton, Gordon B. | 206/343 |
| * | G | US-3,900,925 | 08-1975 | La Torraca, Gerard A. | 24/90.1 |
| * | H | US-4,347,932 | 09-1982 | Furutu, Akira | 206/343 |
| * | I | US-5,671,507 | 09-1997 | Deschenes et al. | 24/114.7 |
| * | J | US-6,173,836 | 01-2001 | Cooper, William J. | 206/346 |
| * | K | US-2005/0199674 | 09-2005 | Lyon, Roy | 227/067 |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|-----------------|-------------|----------------|
| | N | EP 1366994 A1 | 12-2003 | European Patent | UENO et al. | B65C 07/00 |
| | O | JP 2002255132 A | 09-2002 | Japan | UENO et al. | B65C 07/00 |
| | P | WO 2003088191 A1 | 10-2003 | World Intellect | LYON, R | A43D 69/00 |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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